# Covariance methodology applied to uncertainties in I-126 disintegration rate measurements 

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#### Abstract

The covariance methodology applied to uncertainties in ${ }^{126} I$ disintegration rate measurements is described. Two different coincidence systems were used due to the complex decay scheme of this radionuclide. The parameters involved in the determination of the disintegration rate in each experimental system present correlated components. In this case, the conventional statistical methods to determine the uncertainties (law of propagation) result in wrong values for the final uncertainty. Therefore, use of the methodology of the covariance matrix is necessary. The data from both systems were combined taking into account all possible correlations between the partial uncertainties.


## 1. Introduction

The radionuclide ${ }^{126} 1$ is important in fast neutron metrology as a product of the ${ }^{127} 1(n, 2 n)^{126} I$ reaction [1], as well as in nuclear medicine where it appears as an impurity in the reactor production of ${ }^{135}$ I [2]. Therefore, its standardization is of interest. However, due to complex decay characteristics, the absolute measurement of activity requires two detection systems, yielding two set of correlated parameters. The calculation of uncertainties must take these correlations into account.
The decay scheme of ${ }^{126} I[3,4]$ is shown in Fig. 1. This radionuclide decays $52.7 \%$ by electron capture and $\beta^{+}$, and $47.3 \%$ by $\beta^{-}$emission; both branches are followed by $\gamma$-ray emission. Due to its complex decay scheme, the


Fig. 1. Decay scheme of ${ }^{136}[4]$. The values of $a, b$ and $p$ and the half-life were taken from Ref. [3].

[^0]absolute measurement of activity requires two separate coincidence systems.

The $\beta^{-}$(including a small contribution from $\beta^{+}$) branch measurement has been carried out in a $4 \pi(\mathrm{PC}) \beta-\gamma$ coincidence system consisting of a proportional counter, coupled to a pair of $3 \mathrm{in} . \times 3 \mathrm{in} . \mathrm{NaI}(\mathrm{TI})$ crystals. The electron capture branch was measured in a $X-\gamma$ coincidence system using two $3 \mathrm{in} . \times 3 \mathrm{in}$. Nal(TI) crystals.
The data from these two systems are correlated and the corresponding uncertainties cannot be combined by any simple propagation law. The present work describes the covariance methodology applied to uncertainties in disintegration rate measurements for this radionuclide.

## 2. Standardization methods

## 2.I. $X-\gamma$ coincidence method

This method makes use of two scintillation counters. The K X-rays following electron capture events are detected by one of the scintillators whereas the other scintillator detects the photons emitted from the decay of the 666 keV excited state of ${ }^{126} \mathrm{Te}$. Corrections are applied to take into account Compton events under the total absorption peak and possible summing of pulses arising from $K X$-rays in coincidence with $\gamma$-rays.

The number of decay events for this branch is given by:
$N_{v}(a-p)=\frac{N_{\mathrm{x}} N_{\gamma}}{N_{\mathrm{c}}}$,
where $N_{0}(a-p)$ is the disintegration rate of the electron capture branch, $a$ is the probability of electron capture events plus $\beta^{\prime}, p$ is the probability of $\beta^{+}$emission. $N_{x}$ is the K X -ray counting rate in one of the scintillators, $N_{\gamma}$ is the counting rate in the $666 \mathrm{keV} \gamma$-window, and $N_{c}$ is the coincidence rate.

The observed counting rates, $N_{\mathrm{x}}$ and $N_{\gamma}$ were corrected for background. dead time and decay in the usual way. A correction factor due to summing the Compton effects [3] was also considered. The coincidence rate $N_{c}$ was corrected for dead time and accidental coincidences using the Cox-Isham formalism [5].

## 22. $4 \pi \beta-\gamma$ coincidence method

This is the conventional coincidence method using a $4 \pi \beta-\gamma$ system [6], consisting of a $4 \pi$ proportional counter coupled to a pair of $\mathrm{NaI}(\mathrm{TI})$ crystals.

The $\beta^{-}$and $\beta^{+}$particles were detected in the proportional counter. Two discrimination windows were set for the scintillators: one to measure the photons ( $\gamma_{7}$, Fig. 1) emitted in the decay of the 388 keV excited state of ${ }^{26} \mathrm{Xe}$ and another one to measure the photons ( $\gamma_{3}$ ) emitted in the decay of the 666 keV excited state of ${ }^{126} \mathrm{Te}$. This was done to account for the proportional counter sensitivity to X rays and elections.

The $\beta$ branch disintegration rate is given by:
$N_{0}(b+p)=\left[\frac{N_{B} N_{\gamma}}{N_{c}}-N_{\mathrm{G}}(a-p) f_{\mathrm{x}}\right]\left(1+\mathrm{k}_{\varepsilon}\right)^{-1}$.
where $N_{0}(b+p)$ is the disintegration rate corresponding to $\beta^{-}$and $\beta^{+}$branches, $b$ is the $\beta^{-}$emission probability, $p$ is the $\beta^{+}$emission probability, $N_{\beta}$ is the proportional counter counting rate, $N_{\gamma}$ is the counting rate at 388 keV $\gamma$-window, $N_{\mathrm{c}}$ is the coincidence rate, $f_{\mathrm{x}}$ is an experimental correction to account for the sensitivity of the proportional counter to X -rays $[3], 1+k_{z}$ is a measured decay scheme correction [3].

The observed counting rates $N_{\beta}, N_{\gamma}$ and $N_{v}$ were corrected as described in the previuus section.

### 2.3. Activity determination

Since $(a+b)=1$, in principle the activity $N_{0}$ could be obtained by summing Eqs. (1) and (2). However, several parameters on the right hand side of these two equations depend on decay parameters. An alternative procedure has been developed by calculating the following equation:

$$
\begin{align*}
R_{\mathrm{x}}-f_{\mathrm{x}} & =\left(\frac{N_{\mathrm{\beta}} N_{\mathrm{\gamma}}}{N_{\mathrm{y}}} / \frac{N_{\mathrm{x}} N_{\gamma}}{N_{\mathrm{x}}}\right)-f_{\mathrm{x}} \\
& =A\left[1+B\left(\frac{N_{\mathrm{x}}}{N_{\mathrm{x}}}-1\right)\right] . \tag{3}
\end{align*}
$$

where
$A=(b+p) /(a-p)=-\left[1-(a-p)^{-1}\right]$,
$B\left(\frac{N_{\gamma}}{N_{c}}-1\right)=k_{c}$ and
$B$ is the contribution of non-coincident events to the proportional counter detection efficiency.

The parameters $A$ and $B$ were obtained by linear extrapolation, changing the efficiency parameter $N_{\mathrm{c}} / N_{\gamma}$ in the $4 \pi \beta-\gamma$ coincidence system at the $388 \mathrm{keV} \gamma$-window.

The parameter given by Eq. (3) is independent of source activity, mass and irradiation time, therefore sources from different batches could be grouped together in a single extrapolation. From the values of $A$ and ( $a-p$ ), the activity ( $N_{0}$ ) has been obtained by means of Eq. (1).

## 3. Covariance methodology

The covariance matrix is a more complete form of uncertainty representation than the older statistic methods because besides the total uncertainty, it gives information about the existing level of correlation among the partial uncertainties. The method for deriving a covariance matrix $\left(\bar{V}_{i}\right)$ for experimental data has been discussed in detail by many authors (see for instance Refs. [7,8]).
The elements of this matrix can be given by:
$V_{1 i j}=\sum_{i=1}^{i} S_{i, l} e_{i l} e_{j i}$,
where $e_{i l}$ and $e_{j l}$ are the partial uncertainties of the parameters, and $S_{i j t}$ are the corresponding corrclation coefficients.
In order to obtain the final uncertainty in the activity, several steps have been followed:
(1) A covariance matrix involving all relative partial uncertainties in the ratio given by Eq. (3) has been oblained making use of Eq. (4), by means of the code CALCOV [7].
(2) A covariance matrix involving the absolute partial uncertainties in $f_{\mathbf{x}}$ was calculated.
(3) Both matrices were combined by means of code CALCOV [7].
(4) A covariance matrix for the linear square coefficients $A$ and $B$ has been obtained by means of code LSSOLVER [9].

The final uncertainty in the activity has been estimated by:
$\sigma_{N_{0}}^{2}=\sigma_{\Lambda}^{2}+\sigma_{\mathrm{x}}^{2}+2 \rho \sigma_{A} \sigma_{\mathrm{x}}$.
where $\sigma_{A}$ is the uncertainty in parameter $A$ (extrapolated value of $R_{\mathrm{N}}-f_{\mathrm{x}}$ ). $\sigma_{\mathrm{x}}$ is the uncertainty in the right side of Eq. (1). and $\rho$ is the correlation coefficient between both parameters.

Uncertainties are quoted at the $67 \%$ confidence level

Table I
Partial uncertainties in the parameter $R_{N}-f_{\mathrm{x}}(\%)$

| Sample | $4 \pi \beta-\gamma$ | $\mathbf{X - \gamma}$ | $\begin{aligned} & f_{\mathrm{X}}^{2} \\ & \times 10^{-3} \end{aligned}$ | Resolution time | Summing correction | Compton correction $\mathbf{X}-\boldsymbol{\gamma}$ | Compton correction $4 \pi \beta-\gamma$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | 1.38 | 1.48 | 1.65 | 1.10 | 1.10 | 0.17 | 0.61 |
| 2 | 0.84 | 1.69 | 1.59 | 1.10 | 1.10 | 0.17 | 0.61 |
| 3 | 0.54 | 0.61 | 0.95 | 1.10 | 1.10 | 0.17 | 0.61 |
| 4 | 0.49 | 0.63 | 0.80 | 1.10 | 1.10 | 0.17 | 0.61 |
| 5 | 0.75 | 0.85 | 0.98 | 1.10 | 1.10 | 0.17 | 0.61 |
| 6 | 0.40 | 0.66 | 0.86 | 1.10 | 1.10 | 0.17 | 0.61 |
| 7 | 0.91 | 1.69 | 0.88 | 1.10 | 1.10 | 0.17 | 0.61 |
| 8 | 0.63 | 1.09 | 0.71 | 1.10 | 1.10 | 0.17 | 0.61 |
| 9 | 1.58 | 2.63 | 2.51 | 1.10 | 1.10 | 0.17 | 0.61 |
| 10 | 1.31 | 0.61 | 0.57 | 1.10 | 1.10 | 0.17 | 0.61 |
| 11 | 0.45 | 0.45 | 1.08 | 1.10 | 1.10 | 0.17 | 0.61 |
| 12 | 0.34 | 0.62 | 0.57 | 1.10 | 1.10 | 0.17 | 0.61 |
| 13 | 0.56 | 0.45 | 0.41 | 1.10 | 1.10 | 0.17 | 0.61 |
| 14 | 0.60 | 0.48 | 0.72 | 1.10 | 1.10 | 0.17 | 0.61 |
| 15 | 0.61 | 0.56 | 0.53 | 1.10 | 1.10 | 0.17 | 0.61 |
| Correlation factor | 0 | 0 | 0 | 1 | 1 | I | 1 |

${ }^{3}$ Absolute.
( $1 \sigma$ ). The value of $\rho$ has been calculated by the following equation:
$\rho=\frac{\operatorname{cov}\left(R_{\mathrm{N}}, \mathrm{X}\right)}{\sigma_{R_{\mathrm{X}}} \sigma_{\mathrm{X}}}$,
where
$\operatorname{cov}\left(R_{\mathrm{N}}, \mathrm{X}\right)=E\left(\frac{N_{\mathrm{\beta}} N_{\gamma}}{N_{\mathrm{c}}}\right)-E\left(\frac{N_{\mathrm{x}} N_{\gamma}}{N_{\mathrm{c}}}\right) E\left(R_{\mathrm{N}}\right)$,
$E$ corresponds to expected values (averaged) for each irradiation, and $\sigma_{R_{\mathrm{N}}}, \sigma_{\mathrm{x}}$ are the standard deviations in $N_{\mathrm{p}} N_{\gamma} / N_{\mathrm{C}}$ and $N_{\mathrm{x}} N_{\gamma} / N_{\mathrm{c}}$, respectively.

## 4. Results and discussion

Two irradiations have been performed in order to obtain ${ }^{126} I$ by means of the ${ }^{127} \mathrm{I}(\mathrm{n}, 2 \mathrm{n})^{126} \mathrm{I}$ reaction. A total of 15

Table 2
Total uncertainties and correlation matrix for parameter $R_{\mathrm{N}}-f_{\mathrm{x}}$

| Sample | Total absoiute uncertainty ( $\times 10^{-2}$ ) | Corre | ation | atrix |  |  |  |  |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | 1.94 | 100 |  |  |  |  |  |  |  |  |  |  |  |  |  |  |
| 2 | 1.48 | 59 | 100 |  |  |  |  |  |  |  |  |  |  |  |  |  |
| 3 | 1.50 | 58 | 78 | 100 |  |  |  |  |  |  |  |  |  |  |  |  |
| 4 | 1.50 | 57 | 77 | 76 | 100 |  |  |  |  |  |  |  |  |  |  |  |
| 5 | 1.53 | 56 | 76 | 75 | 74 | 100 |  |  |  |  |  |  |  |  |  |  |
| 6 | 1.56 | 55 | 75 | 73 | 73 | 71 | 100 |  |  |  |  |  |  |  |  |  |
| 7 | 2.47 | 35 | 47 | 46 | 46 | 45 | 44 | 100 |  |  |  |  |  |  |  |  |
| 8 | 2.41 | 37 | 50 | 48 | 48 | 47 | 46 | 29 | 100 |  |  |  |  |  |  |  |
| 9 | 1.59 | 55 | 75 | 73 | 73 | 72 | 70 | 45 | 47 | 100 |  |  |  |  |  |  |
| 10 | 1.57 | 56 | 75 | 74 | 73 | 72 | 71 | 45 | 47 | 71 | 100 |  |  |  |  |  |
| 11 | 1.78 | 49 | 67 | 65 | 65 | 64 | 62 | 40 | 41 | 62 | 63 | 100 |  |  |  |  |
| 12 | 1.57 | 56 | 76 | 74 | 74 | 73 | 71 | 45 | 47 | 71 | 72 | 63 | 100 |  |  |  |
| 13 | 2.38 | 36 | 49 | 48 | 48 | 47 | 46 | 29 | 30 | 46 | 46 | 41 | 47 | 100 |  |  |
| 14 | 1.91 | 47 | 63 | 62 | 61 | 60 | 59 | 38 | 39 | 59 | 60 | 53 | 60 | 39 | 100 |  |
| 15 | 3.39 | 25 | 34 | 33 | 33 | 33 | 32 | 20 | 21 | 32 | 32 | 28 | 32 | 21 | 27 | 100 |



Fig. 2. Extrapolation curve between ( $R_{\mathrm{N}}-f_{\mathrm{x}}$ ) as a function of the inefficiency factor $\left(N_{\gamma} / N_{c}-1\right)$.
sources have been standardized. A list of all partial uncertainties involved in Eqs. (2) and (3) are listed in Table 1. The correlation coefficients are shown in the bottom of the table. The first two columns give the total uncorrelated uncertainties calculated from the measurements using the two coincidence systems, namely: $4 \pi \beta-\gamma$ and $X-\gamma$. These uncertainties were obtained by simple propagation of all partial uncertainties involved. The third column gives the uncertainty in $f_{\mathrm{x}}$. The main contribution to this uncertainty was in the $4 \boldsymbol{\pi}$ detection efficiency for X-rays. All other uncertainties shown in Table 1 are systematic and were assumed to be totally correlated. Table 2 shows the total uncertainties and the corresponding
correlation matrix calculated by code CALCOV [7]. These values were used as input data for the linear fit presented in Fig. 2. This fit has been performed by code LSSOLVER [9] taking into account the input correlation matrix.

Fig. 2 shows the extrapolation curve applying Eq. (3). The final uncertainty in the activity for each sample was obtained from the data given in Tables 1 and 2, by means of Eq. (5).

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